

<b>Notice of References Cited</b>	Application/Control No. 10/587,729	Applicant(s)/Patent Under Reexamination VELDHUIZEN ET AL.	
	Examiner Christopher R. Lea	Art Unit 1619	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0013708	01-2004	Goulson et al.	424/439
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 0033669 A1	06-2000	World Intellect	DAHLSTEN C-J et al.	
	O					
	P					
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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